

<b>Notice of References Cited</b>	Application/Control No. 10/544,231	Applicant(s)/Patent Under Reexamination FUJINE, TOSHIYUKI	
	Examiner Hoai-Quan T. Ho	Art Unit 2629	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,161,576	01-2007	Kawabe et al.	345/99
*	B	US-7,084,861	08-2006	Iisaka, Hidehito	345/204
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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